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	Filing Date		2007-02-08	
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	4	6593511	B1	2003-07-15	Ehrhardt, Rolf	
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	1	WO2001067103	WO		A1	2001-09-13	Berg, Ellen L.				
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	3	WO2003023573	wo	A2	2003-03-20	Berg, Ellen L.		
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